

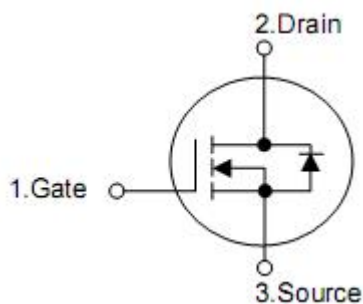
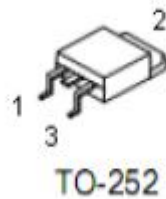
1. Features

- Trench Power LV MOSFET technology
- Excellent package for heat dissipation
- High density cell design for low $R_{DS(ON)}$

2. Features

- High current load applications
- Low On-Resistance (typ.) $R_{DS(on)}=7.0m\Omega$
- Load switching
- Hard switched and high frequency circuits
- Uninterruptible power supply

3. Pin configuration



Pin	Function
1	Gate
2	Drain
3	Source

4. Ordering Information

Part Number	Package	Brand
KND3504A	TO-252	KIA

5. Absolute maximum ratings

TC=25 °C unless otherwise specified

Parameter	Symbol	Ratings	Unit
Drain-to-Source Voltage	V_{DSS}	40	V
Continuous Drain Current	I_D	$T_C=25\text{ °C}$	70
		$T_C=100\text{ °C}$	49
Pulsed drain current ^(note1)	I_{DM}	270	A
Avalanche energy ^(note2)	E_{AS}	110	mJ
Gate-Source voltage	V_{GS}	±20	V
Power dissipation	P_D	$T_C=25\text{ °C}$	48
		$T_C=100\text{ °C}$	24
Thermal resistance, Junction-case ^(note3)	$R_{\theta JC}$	3.1	°C/W
Junction & Storage Temperature Range	T_J & T_{STG}	-55 to 150	°C

6. Electrical characteristics

(T_J=25°C, unless otherwise notes)

Parameter	Symbol	Conditions	Min	Typ	Max	Units	
Static characteristics							
Drain-source breakdown voltage	BV _{DSS}	V _{GS} =0V, I _D =250μA	40	-	-	V	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =32V, V _{GS} =0V	T _J =25°C	-	-	1	μA
			T _J =55°C	-	-	5	
Gate threshold voltage	V _{GS(th)}	V _{DS} =V _{GS} , I _D =250μA	0.7	1.2	2.5	V	
Gate leakage current	I _{GSS}	V _{GS} =±20V, V _{DS} =0V	-	-	±100	nA	
Drain-source on-resistance	R _{DS(on)}	V _{GS} =10V, I _D =20A	-	7.0	8.5	mΩ	
		V _{GS} =4.5V, I _D =10A	-	8.0	10.5		
Dynamic characteristics							
Input capacitance	C _{iss}	V _{DS} =20V, V _{GS} =0V, F=1MHz	-	1760	-	pF	
Output capacitance	C _{oss}		-	220	-	pF	
Reverse transfer capacitance	C _{rss}		-	190	-	pF	
Turn-on delay time	t _{d(on)}	V _{DD} =20V, I _D =2A, V _{GS} =10V, R _G =3Ω	-	5	-	ns	
Rise time	t _r		-	22	-	ns	
Turn-off delay time	t _{d(off)}		-	50	-	ns	
Fall time	t _f		-	32	-	ns	
Gate Charge Characteristics							
Total gate charge	Q _g	V _{DS} =20V, I _D =20A, V _{GS} =10V	-	46.5	-	nC	
Gate-source charge	Q _{gs}		-	5.6	-	nC	
Gate-drain charge	Q _{gd}		-	10.5	-	nC	
Diode characteristics							
Diode forward voltage	V _{SD}	V _{GS} =0V, I _S =20A	-	0.85	1.3	V	
Body Diode Continuous Forward Current	I _S		-	-	70	A	
Reverse recovery time	t _{rr}	I _F =20A DI _F /dt=100A/μs	-	8.5	-	ns	
Reverse recovery charge	Q _{rr}		-	0.5	-	nC	

NOTE:

1. Pulse Test: Pulse Width ≤ 300μs, Duty cycle ≤ 2%.
2. V_{DD}=40V, V_{GS}=10V, L=0.5mH, I_D=20A
3. R_{θJA} is the sum of the junction-to-case and case-to-ambient thermal resistance, where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{θJC} is guaranteed by design, while R_{θJA} is determined by the board design. The maximum rating presented here is based on mounting on a 1 in 2 pad of 2oz copper.

7. Typical Characteristics

■ Typical Performance Characteristics

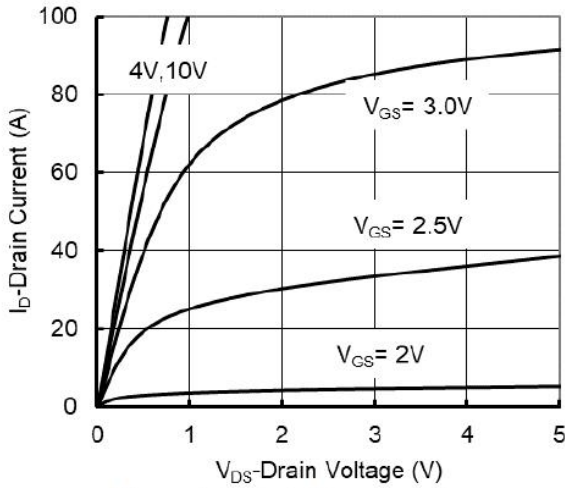


Figure 1. Output Characteristics

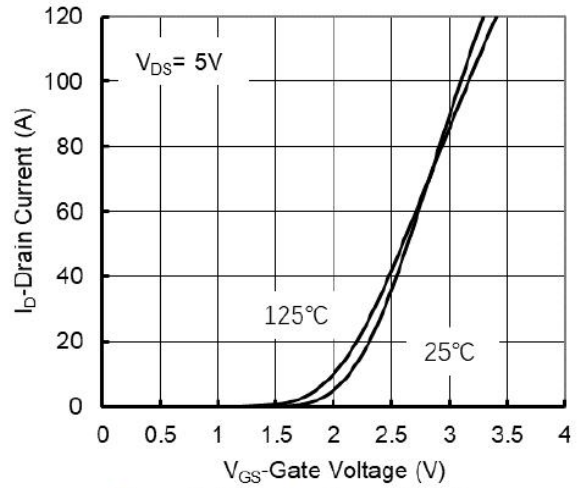


Figure 2. Transfer Characteristics

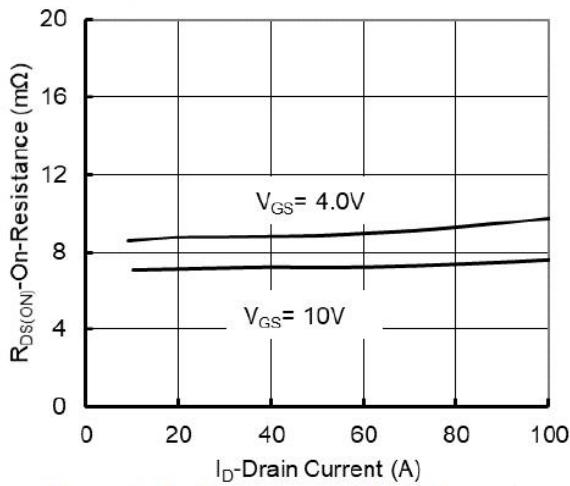


Figure 3. On-Resistance vs. Drain Current and Gate Voltage

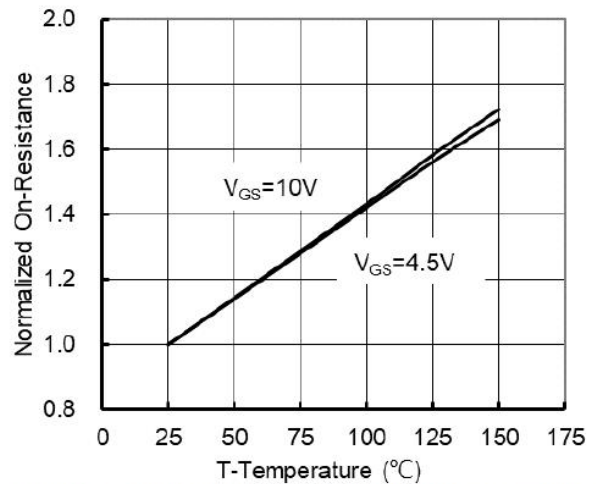


Figure 4. On-Resistance vs. Junction Temperature

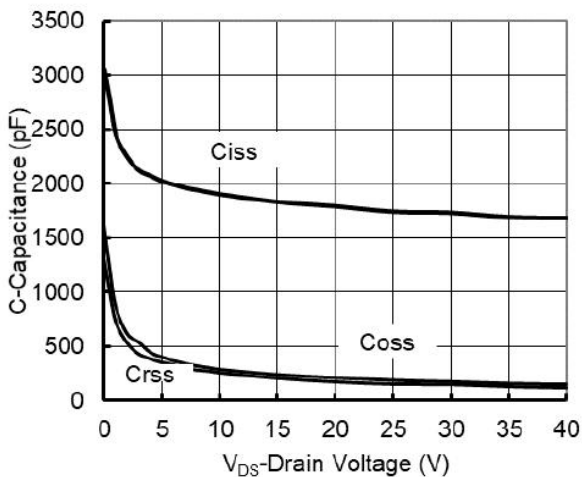


Figure 5. Capacitance Characteristics

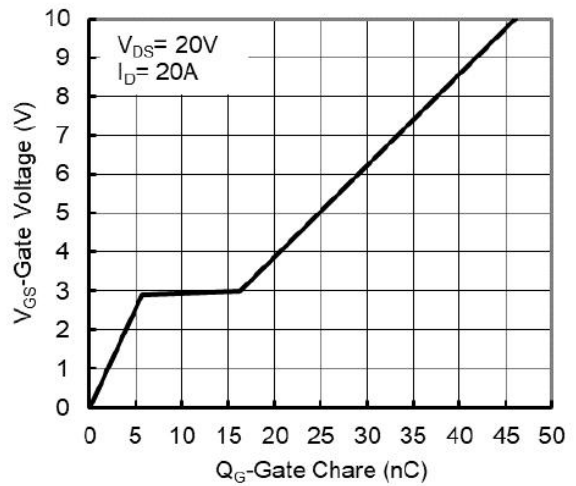


Figure 6. Gate Charge

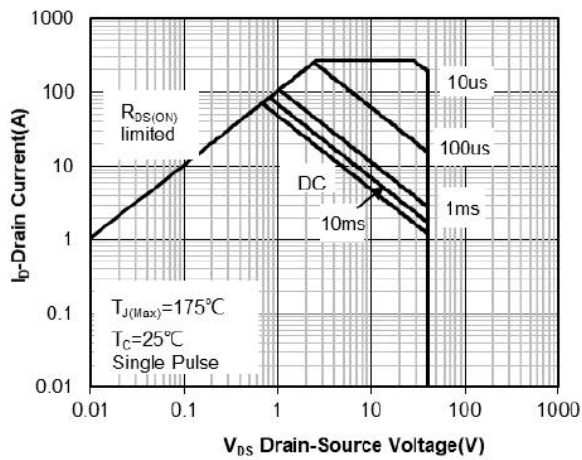


Figure 7. Safe Operation Area

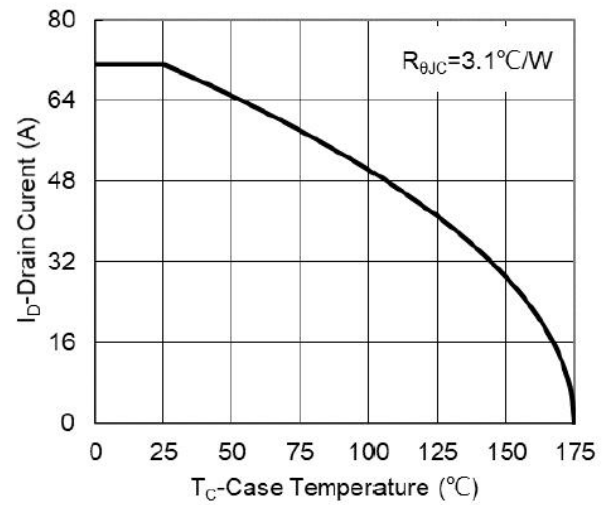


Figure 8. Maximum Continuous Drain Current vs Case Temperature

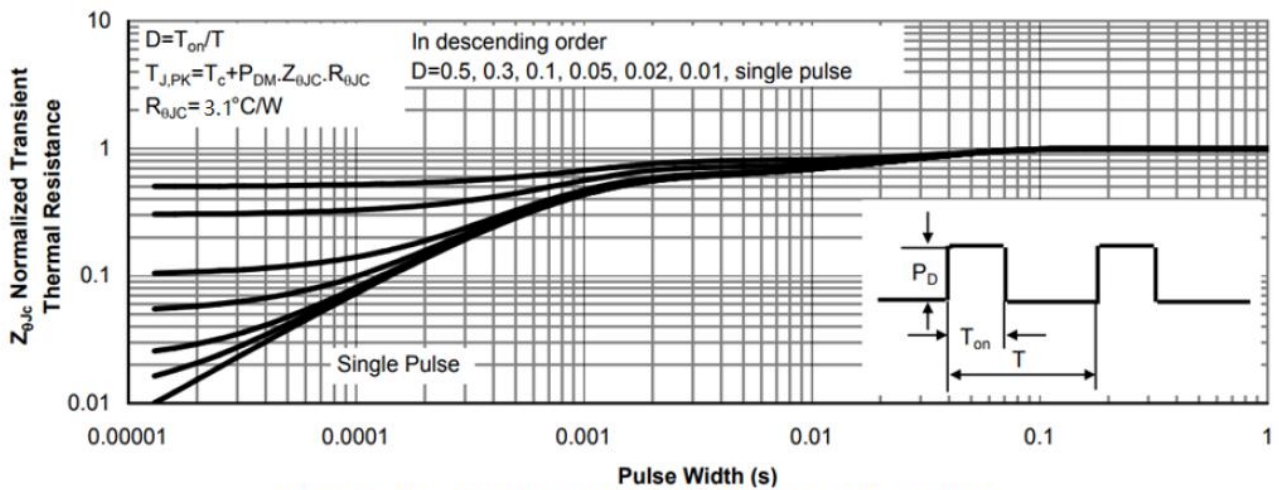


Figure 9. Normalized Maximum Transient Thermal Impedance